CLAIMS

We claim:

- 1 l. A circuit comprising:
- a diode string coupled to a supply voltage line; and
- 3 a transistor coupled to the diode string and to a reference
- 4 voltage line, wherein the diode string and the transistor are
- 5 implemented in a cascode configuration and provide electrostatic
- 6 discharge protection.
- 1 2. The circuit of Claim 1, wherein the diode string
- 2 comprises:
- 3 at least a first diode coupled between the supply voltage
- 4 line and the reference voltage line and adapted to provide
- 5 electrostatic discharge protection having a first polarity; and
- 6 at least a second diode coupled to the supply voltage line
- 7 and adapted to provide electrostatic discharge protection having
- 8 a second polarity.
- 1 3. The circuit of Claim 2, wherein the second diode has
- 2 at least a first terminal coupled to a drain terminal of the
- 3 transistor.
- 1 4. The circuit of Claim 1, wherein the transistor and the
- 2 diode string have different diffusion regions.

- 1 5. The circuit of Claim 1, further comprising a resistor
- 2 coupled between a gate terminal of the transistor and the
- 3 reference voltage line, wherein the circuit provides
- 4 electrostatic discharge protection for a power rail of an
- 5 integrated circuit incorporating the circuit.
- 1 6. The circuit of Claim 1, further comprising a pull-up
- 2 circuit coupled between the supply voltage line and the diode
- 3 string, wherein the pull-up circuit and the diode string are
- 4 coupled to an input pad and/or an output pad, the transistor is
- 5 adapted to receive a control signal at its gate terminal, and
- 6 the circuit provides electrostatic discharge protection for an
- 7 interface of an integrated circuit incorporating the circuit.
- 1 7. The circuit of Claim 6, wherein the circuit is adapted
- 2 to operate as a driver.
- 1 8. The circuit of Claim 1, wherein the circuit is adapted
- 2 to operate in a mixed voltage environment.
- 1 9. The circuit of Claim 1, wherein one or more diodes
- 2 within the diode string may be implemented as bipolar
- 3 transistors.

- 1 10. A programmable logic device comprising:
- 2 at least a first diode coupled between a supply voltage
- 3 line and a reference voltage line and adapted to protect from
- 4 electrostatic discharge of a first polarity;
- 5 at least a second diode coupled between the supply voltage
- 6 line and the reference voltage line and adapted to protect from
- 7 electrostatic discharge of a second polarity; and
- 8 a transistor coupled between the at least first diode and
- 9 the reference voltage line.
- 1 11. The programmable logic device of Claim 10, wherein the
- 2 transistor and the at least first diode are implemented in a
- 3 cascode configuration and adapted to operate in a mixed voltage
- 4 environment.
- 1 12. The programmable logic device of Claim 11, wherein the
- 2 transistor and the at least first diode have different diffusion
- 3 regions.
- 1 13. The programmable logic device of Claim 10, further
- 2 comprising a resistor coupled between a gate terminal of the
- 3 transistor and the reference voltage line, wherein the at least
- 4 first diode, the at least second diode, the transistor, and the
- 5 resistor provide electrostatic discharge protection for a power
- 6 rail of the programmable logic device.

- 1 14. The programmable logic device of Claim 10, wherein the
- 2 at least second diode has a first terminal coupled to a drain
- 3 terminal of the transistor.
- 1 15. The programmable logic device of Claim 10, further
- 2 comprising a pull-up circuit coupled between the supply voltage
- 3 line and the at least first diode, wherein the pull-up circuit
- 4 and the at least first diode are coupled to a pad, the
- 5 transistor is adapted to receive a control signal at its gate
- 6 terminal, and the at least first diode, the at least second
- 7 diode, and the transistor provide electrostatic discharge
- 8 protection for an interface of the programmable logic device.
- 1 16. The programmable logic device of Claim 10, wherein the
- 2 at least first diode and/or the at least second diode comprise a
- 3 bipolar transistor.
- 1 17. A method of providing electrostatic discharge
- 2 protection, the method comprising:
- 3 providing at least a first diode coupled to a supply
- 4 voltage rail to protect from electrostatic discharge of a first
- 5 polarity;
- 6 providing a transistor coupled between the at least first
- 7 diode and a reference voltage rail; and
- 8 providing at least a second diode coupled to the supply
- 9 voltage rail and to the reference voltage rail or between the at
- 10 least first diode and the transistor to protect from
- 11 electrostatic discharge of a second polarity, wherein the at

- 12 least first diode and the transistor are implemented in a
- 13 cascode configuration.
- 1 18. The method of Claim 17, wherein the at least first
- 2 diode and the transistor are implemented having different
- 3 diffusions.
- 1 19. The method of Claim 17, further comprising operating
- 2 the at least first diode, the at least second diode, and the
- 3 transistor as a clamp circuit.
- 1 · 20. The method of Claim 17, further comprising operating
- 2 the at least first diode, the at least second diode, and the
- 3 transistor as a driver to transfer data via a pad.
- 1 21. The method of Claim 17, further comprising providing a
- 2 pull-up circuit between the supply voltage rail and the at least
- 3 first diode.
- 1 22. The method of Claim 17, wherein the at least first
- 2 diode and/or the at least second diode comprise a bipolar
- 3 transistor.